



N-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

Device	BV _{DSS}	R _{DS(ON)} Max	I _D Max T _C = +25°C (Note 10)
		11.1m Ω @ V _{GS} = 10V	30A
Q1 & Q2	30V	$13.8 \text{m}\Omega$ @ $V_{GS} = 4.5 \text{V}$	28A
		$22.0 \text{m}\Omega$ @ $V_{GS} = 3.8V$	22A

Features and Benefits

- Low Gate Threshold Voltage
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)

Description

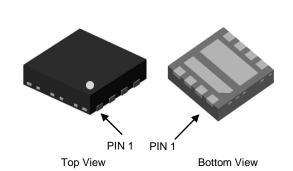
This new generation MOSFET is designed to minimize the on-state resistance (R_{DS(ON)}), yet maintain superior switching performance, making it ideal for high-efficiency power management applications.

Applications

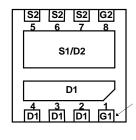
- General Purpose Interfacing Switch
- Power Management Functions

Mechanical Data

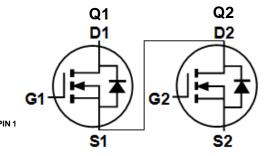
- Case: V-DFN3030-8 (Type K)
- Case Material: Molded Plastic, "Green" Molding Compound.
 UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish NiPdAu over Copper Leadframe.
 Solderable per MIL-STD-202, Method 208
- Weight: 0.02 grams (Approximate)



V-DFN3030-8 (Type K)







Equivalent Circuit

Ordering Information (Note 4)

Part Number	Case	Tape Width	Tape Pitch	Packaging
DMT3009LDT-7	V-DFN3030-8 (Type K)	8mm	4mm	3,000/Tape & Reel
DMT3009LDT-7A	V-DFN3030-8 (Type K)	12mm	8mm	1,500/Tape & Reel

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.
- See http://www.diodes.com/quality/lead_free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/

Marking Information

V-DFN3030-8 (Type K)



T30= Product Type Marking Code YYWW = Date Code Marking YY = Last Two Digits of Year (ex: 18 = 2018) WW = Week Code (01 to 53)



Characteristic	Symbol	Q1&Q2	Unit		
Drain-Source Voltage	V _{DSS}	30	V		
Gate-Source Voltage			V_{GSS}	+20, -16	V
Continuous Drain Current (Note C) V 40V	Steady State (Note 10)	$T_C = +25$ °C $T_C = +70$ °C	I _D	30 25	А
Continuous Drain Current (Note 6) V _{GS} = 10V	t<10s	$T_A = +25$ °C $T_A = +70$ °C	I _D	14 11	А
Maximum Body Diode Forward Current (Note 6)	Is	2.1	Α		
Pulsed Drain Current (100µs Pulse, Duty Cycle = 1%)	I _{DM}	80	Α		
Pulsed Body Diode Forward Current (370µs Pulse, Duty C	I _{SM}	80	Α		
Avalanche Current (Note 7) L = 0.1mH	I _{AS}	19.3	Α		
Avalanche Energy (Note 7) L = 0.1mH	E _{AS}	18.6	mJ		

Thermal Characteristics

Characteristic	Symbol	Value	Unit	
Total Power Dissipation (Note 5)	T _A = +25°C	0	1.2	W
Total Power Dissipation (Note 5)	$T_A = +70^{\circ}C$	P _D	0.8	
Thermal Resistance, Junction to Ambient (Note 5)	Steady State	D	107	°C/W
Thermal Resistance, Junction to Ambient (Note 5)	t<10s	$R_{\theta JA}$	63	
Total Dawer Dissination (Note 6)	$T_A = +25^{\circ}C$	0	2.0	W
Total Power Dissipation (Note 6)	T _A = +70°C	P _D	1.2	
Thermal Peciatones, Junction to Ambient (Note 6)	Steady State	D	64	°C/W
Thermal Resistance, Junction to Ambient (Note 6)	t<10s	$R_{\theta JA}$	39	
Thermal Resistance, Junction to Case (Note 6)		R _{eJC}	7.6	
Operating and Storage Temperature Range		T _{J,} T _{STG}	-55 to +150	°C

Notes:

- Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.
 Device mounted on FR-4 substrate PC board, 2oz copper, with 1-inch square copper plate.
- 7. UIS in production with L = 0.1mH, starting $T_A = +25$ °C.



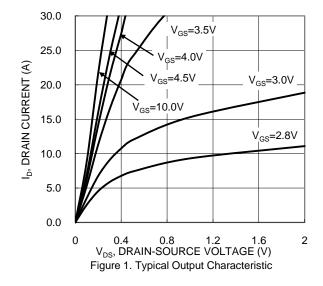
Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

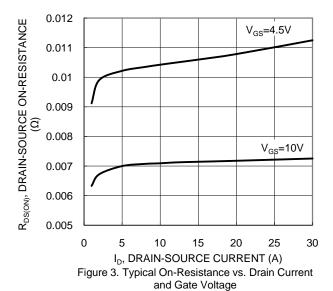
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 8)						
Drain-Source Breakdown Voltage	BV _{DSS}	30	_	_	V	$V_{GS} = 0V, I_D = 250\mu A$
Zero Gate Voltage Drain Current	I _{DSS}		1	1	μΑ	$V_{DS} = 24V$, $V_{GS} = 0V$
Zero Gate Voltage Drain Current T _J = +150°C (Note 9)	I _{DSS}		ı	100	μΑ	$V_{DS} = 24V$, $V_{GS} = 0V$
Gate-Source Leakage	I _{GSS}		_	±100	nA	$V_{GS} = 20V, V_{DS} = 0V$ $V_{GS} = -16V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 8)						
Gate Threshold Voltage	V _{GS(TH)}	1	1	3	٧	$V_{DS} = V_{GS}$, $I_D = 250\mu A$
			7.2	11.1		$V_{GS} = 10V, I_D = 14.4A$
Static Drain-Source On-Resistance	R _{DS(ON)}		10.5	13.8	mΩ	$V_{GS} = 4.5V, I_D = 7A$
			13	22.0		$V_{GS} = 3.8V, I_D = 5A$
Diode Forward Voltage	V_{SD}			1.2	٧	$V_{GS} = 0V, I_{S} = 10A$
DYNAMIC CHARACTERISTICS (Note 9)						
Input Capacitance	C _{iss}	_	748	1,500		$V_{DS} = 15V, V_{GS} = 0V, f = 1.0MHz$
Output Capacitance	Coss		447	895	pF	
Reverse Transfer Capacitance	Crss	_	43	90		
Gate Resistance	R_{g}		1.0	2.0	Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1.0MHz$
Total Gate Charge (V _{GS} = 10V)	Q_{g}	_	13.8	20		
Total Gate Charge (V _{GS} = 4.5V)	Q_g		6.4	9	nC	V _{DS} = 15V. I _D = 14.4A
Gate-Source Charge	Q_gs		2.2	5	110	VDS = 13V, ID = 14.4A
Gate-Drain Charge	Q_{gd}		2.2	5		
Turn-On Delay Time	t _{D(ON)}		3.5	7		$V_{GS} = 10V$, $V_{DD} = 15V$, $R_g = 1\Omega$, $I_D = 10A$
Turn-On Rise Time	t _R		5.0	10	ns	
Turn-Off Delay Time	t _{D(OFF)}	_	8.6	17	115	
Turn-Off Fall Time	t _F		1.4	3		
Body Diode Reverse Recovery Time	t _{RR}		18	33	ns	$I_F = 10A$, $di/dt = 100A/\mu s$
Body Diode Reverse Recovery Charge	Q_{RR}		7.7	15	nC	$I_F = 10A$, di/dt = $100A/\mu s$

Notes:

Short duration pulse test used to minimize self-heating effect.
 Guaranteed by design. Not subject to product testing.
 Package limited.







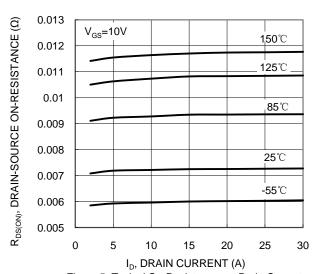
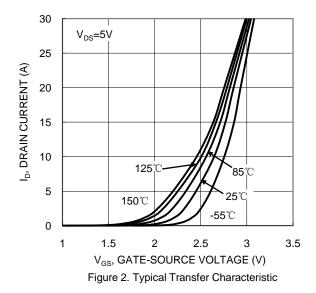
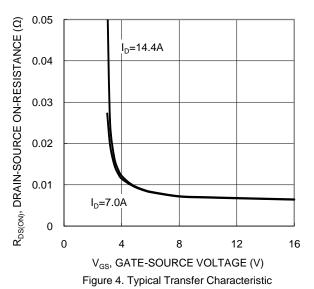


Figure 5. Typical On-Resistance vs. Drain Current and Junction Temperature





1.8 R_{DS(ON)}, DRAIN-SOURCE ON-RESISTANCE (NORMALIZED) V_{GS}=4.5V, I_D=7.0A 1.6 $V_{GS} = 10V, I_{D} = 14.4A$ 1.4 1.2 1 V_{GS} =3.8V, I_{D} =5.0A 0.8 0.6 -50 25 50 75 100 125 150 T_J, JUNCTION TEMPERATURE (°C)

Figure 6. On-Resistance Variation with Junction Temperature



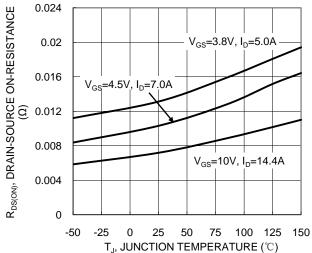
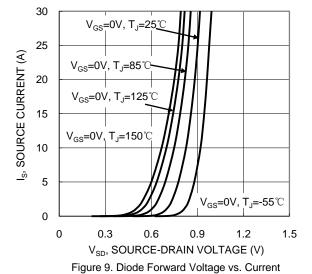


Figure 7. On-Resistance Variation with Junction Temperature



10

15

V_{DS}, DRAIN-SOURCE VOLTAGE (V)

Figure 11. Typical Junction Capacitance

20

25

30

2 V_{GS(TH),} GATE THRESHOLD VOLTAGE (V) 1.8 1.6 I_D=1mA 1.4 1.2 1 $I_D=250\mu A$ 0.8 0.6 -50 50 75 100 125 150 0 25 T_J , JUNCTION TEMPERATURE (°C) Figure 8. Gate Threshold Variation vs. Junction

Temperature

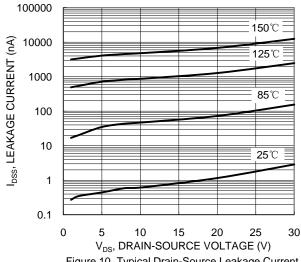
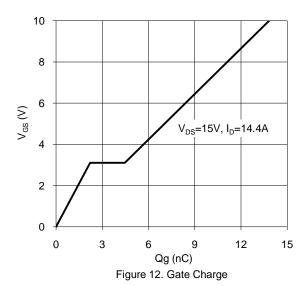


Figure 10. Typical Drain-Source Leakage Current vs. Voltage

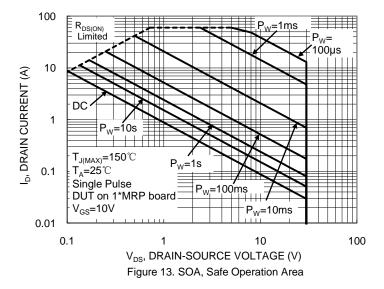


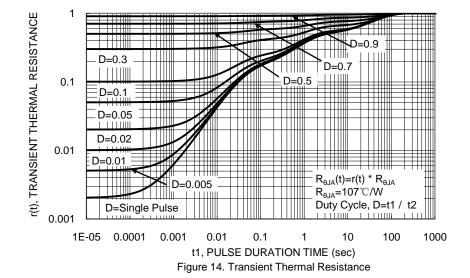
10000

10

0





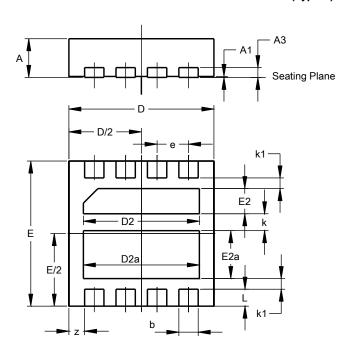




Package Outline Dimensions

Please see http://www.diodes.com/package-outlines.html for the latest version.

V-DFN3030-8 (Type K)

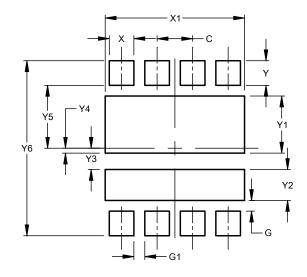


V-DFN3030-8						
(Type K)						
Dim	Min	Max	Тур			
Α	0.77	0.85	0.80			
A1	0.00	0.05	0.02			
А3	C	.20BSC				
b	0.35	0.45	0.40			
D	2.95	3.050	3.00			
D2	2.30	2.50	2.40			
D2a	2.30	2.50	2.40			
Е	2.95	3.050	3.00			
E2	0.42 0.62		0.52			
E2a	0.89 1.09 0.99		0.99			
е	0.65BSC					
k	-	-	0.35			
k1	-	-	0.22			
L	0.30	0.40	0.35			
Z	0.325BSC					
All Dimensions in mm						

Suggested Pad Layout

Please see http://www.diodes.com/package-outlines.html for the latest version.

V-DFN3030-8 (Type K)



Dimensions	Value		
Dilliciisions	(in mm)		
С	0.650		
G	0.195		
G1	0.200		
Х	0.450		
X1	2.550		
Υ	0.450		
Y1	1.044		
Y2	0.566		
Y3	0.389		
Y4	0.089		
Y5	1.150		
Y6	3.200		



IMPORTANT NOTICE

DIODES INCORPORATED MAKES NO WARRANTY OF ANY KIND, EXPRESS OR IMPLIED, WITH REGARDS TO THIS DOCUMENT, INCLUDING, BUT NOT LIMITED TO, THE IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A PARTICULAR PURPOSE (AND THEIR EQUIVALENTS UNDER THE LAWS OF ANY JURISDICTION).

Diodes Incorporated and its subsidiaries reserve the right to make modifications, enhancements, improvements, corrections or other changes without further notice to this document and any product described herein. Diodes Incorporated does not assume any liability arising out of the application or use of this document or any product described herein; neither does Diodes Incorporated convey any license under its patent or trademark rights, nor the rights of others. Any Customer or user of this document or products described herein in such applications shall assume all risks of such use and will agree to hold Diodes Incorporated and all the companies whose products are represented on Diodes Incorporated website, harmless against all damages.

Diodes Incorporated does not warrant or accept any liability whatsoever in respect of any products purchased through unauthorized sales channel. Should Customers purchase or use Diodes Incorporated products for any unintended or unauthorized application, Customers shall indemnify and hold Diodes Incorporated and its representatives harmless against all claims, damages, expenses, and attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized application.

Products described herein may be covered by one or more United States, international or foreign patents pending. Product names and markings noted herein may also be covered by one or more United States, international or foreign trademarks.

This document is written in English but may be translated into multiple languages for reference. Only the English version of this document is the final and determinative format released by Diodes Incorporated.

LIFE SUPPORT

Diodes Incorporated products are specifically not authorized for use as critical components in life support devices or systems without the express written approval of the Chief Executive Officer of Diodes Incorporated. As used herein:

- A. Life support devices or systems are devices or systems which:
 - 1. are intended to implant into the body, or
 - 2. support or sustain life and whose failure to perform when properly used in accordance with instructions for use provided in the labeling can be reasonably expected to result in significant injury to the user.
- B. A critical component is any component in a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or to affect its safety or effectiveness.

Customers represent that they have all necessary expertise in the safety and regulatory ramifications of their life support devices or systems, and acknowledge and agree that they are solely responsible for all legal, regulatory and safety-related requirements concerning their products and any use of Diodes Incorporated products in such safety-critical, life support devices or systems, notwithstanding any devices- or systems-related information or support that may be provided by Diodes Incorporated. Further, Customers must fully indemnify Diodes Incorporated and its representatives against any damages arising out of the use of Diodes Incorporated products in such safety-critical, life support devices or systems.

Copyright © 2018, Diodes Incorporated

www.diodes.com